

S arch Notes

Application/Control No.

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Examiner

Daniel Tekle

Applicant(s)/Patent und r
R xamination

SCHRADER, EDWARD M.

Art Unit

2633

SEARCHED

Class	Subclass	Date	Examiner
386	96	5/6/2006	DT
386	97	5/6/2006	DT
386	94	5/6/2006	DT
348	468	5/6/2006	DT
386	1	5/6/2006	DT
386	46	5/15/2006	DT
704	275	5/15/2006	DT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
List data base search in East (US-PGPUB, USPAT, USOCR, EPO, JPO, DEWENT, IBM_TDB) see search history attached	5/6/2006	DT
NPL ACM DIGITAL LIBRARY, IEEE Xplore, IP.COM see search history attached	5/6/2006	DT
PLUS See search history attached	5/6/2006	DT
inventor name search	5/6/2006	DT